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10/015,983 Examiner

Thuy N. Pardo

Applicant(s)/Patent under Reexamination

DESBIENS ET AL.

Art Unit

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	SEAR	CHED	
Class	Subclass	Date	Examiner
Class Fof V Fo6	Subclass 101 102 103R 104.1 4 7 8 26 10 45	Date 8/25/06	TP

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
707	101	8/25/06	TP	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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WEST IEEE				
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